

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





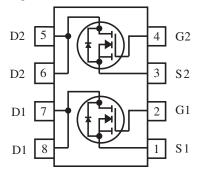


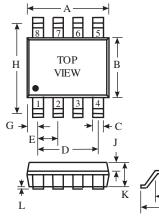


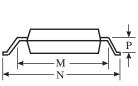
DUAL N-CHANNEL ENHANCEMENT MODE FIELD EFFECT TRANSISTOR

Features

- High Cell Density DMOS Technology
- Lower On-State Resistance
- High Power and Current Capability
- Fast Switching Speed
- High Transient Tolerance







SO-8				
Dim	Min	Max		
Α	3.94	4.19		
В	3.20	3.40		
С	0.381	0.495		
D	2.67	3.05		
Е	0.89	1.02		
G	0.527	0.679		
J	0.41 Nominal			
K	0.94	1.09		
L	0.025 0.152			
M	4.37	4.62		
N	4.39	4.70		
Р	0.939 Nominal			
All Dimensions in mm				

Mechanical Data

- SO-8 Plastic Case
- Terminal Connections: See Outline Drawing and Internal Circuit Diagram above

Maximum Ratings @ T_A = 25°C unless otherwise specified

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		V_{DSS}	30	V
Gate-Source Voltage		V _{GSS}	±20	V
Drain Current	Note 1a Continuous Pulsed	I _D	±3.7 ±15	А
Power Dissipation for:	Dual Operation (Note 1d) Single Operation (Note 1a) (Note 1b) (Note 1c)	Pd	2.0 1.6 1.0 0.9	W
Operating and Storage Temperature Range		T _j , T _{STG}	-55 to +150	°C

Thermal Characteristics @ T_A = 25°C unless otherwise specified

Characteristic		Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	Note 1a	$R_{\Theta JA}$	78	°C/W
Thermal Resistance, Junction-to-Case	Note 1	R _⊝ JC	40	°C/W

Notes: 1. R_{OJA} is the sum of the junction-to-case and case-to-ambient thermal resistance (R_{OJC} + R_{OCA}) where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{OJC} in this instance is 40°C/W but is dependent on the specific circuit board thermal design.

- 1a. With 0.5 in 2 of 2 oz. copper mounting pad $R_{\Theta JA} = 78^{\circ}C \setminus W$.
- 1b. With 0.02 in of 2 oz. copper mounting pad $R_{\Theta JA = 125^{\circ}C/W}$.
- 1c. With 0.003 in 2 of 2 oz. copper mounting pad $R_{\Theta JA = 135^{\circ}C \setminus W}$.
- 1d. With 1.0 in of 2 oz. copper mounting pad, total power dissipation of up to 2W for dual operation can be achieved

Electrical Characteristics @ T_A = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS					•	
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current T _j = 55°C	I _{DSS}	_	_	2.0 25	μΑ	V _{DS} = 24V, V _{GS} = 0V
Gate-Body Leakage, Forward	IGSSF	_	_	100	nA	V _{GS} = 20V, V _{DS} = 0V
Gate-Body Leakage, Reverse	Igssr	_	_	-100	nA	$V_{GS} = -20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 2)						
Gate Threshold Voltage $T_j = 125$ °C	V _{GS(th)}	1.0 0.7	1.7 1.2	2.8 2.2	V	$VDS = V_{GS}, I_D = 250\mu A$
Static Drain-Source On-Resistance $T_j = 125$ °C $T_i = 125$ °C	R _{DS} (ON)	_	0.06 0.08 0.08 0.11	0.08 0.13 0.11 0.18	Ω	V _{GS} = 10V, I _D = 2.2A V _{GS} = 10V, I _D = 2.2A V _{GS} = 4.5V, I _D = 1.0A V _{GS} = 4.5V, I _D = 1.0A
On-State Drain Current	I _{D(ON)}	15 3.5	_	_	А	V _{GS} = 10V, V _{DS} = 10V V _{GS} = 4.5V, V _{DS} = 10V
Forward Transconductance	g _{FS}	_	6.0	_	Ω	V _{DS} = 15V, I _D = 3.7A
DYNAMIC CHACTERISTICS			-	1	1	
Input Capacitance	Ciss	_	320	_	pF	10// 1
Output Capacitance	Coss	_	225	_	pF	$V_{DS} = 10V, V_{GS} = 0V$ f = 1.0MHz
Reverse Transfer Capacitance	CRSS	_	85	_	pF	
SWITCHING CHARACTERISTICS (No	te 2)		•		•	
Turn-On Delay Time	tD(ON)	_	10	20	ns	
Turn-On Rise Time	t _r	_	13	20	ns	$V_{DD} = 10V, I_{D} = 1.0A$
Turn-Off Delay Time	t _{D(OFF)}	_	21	50	ns	$V_{GEN} = 10V, R_{GEN} = 6.0\Omega$
Turn-Off Fall Time	t _f	_	5.0	50	ns	
Total Gate Charge	Qg	_	9.5	27	nC	V _{DS} =10V, I _D = 3.7A. V _{GS} = 10V
Gate-Source Charge	Qgs	_	1.5	_	nC	
Gate-Drain Charge	Q _{gd}	_	3.3	_	nC	
DRAIN-SOURCE DIODE CHARACTE	RISTICS AND	MAXIMUM	RATINGS			
Max Continuous Drain-Source Diode Forward Current	Is	_	_	1.2	А	
Drain-Source Diode Forward Voltage	V _{SD}		0.8	1.3	V	V _{GS} = 0V, I _S = 1.25A (Note 2)
Reverse Recovery Time	t _{rr}	_		100	ns	$V_{GS} = 0V$, $I_F = 1.25A$, $dI_F/dt = 100A/\mu s$

Note: 2. Pulse Test: Pulse width \leq 300 μ s duty cycle \leq 2%.

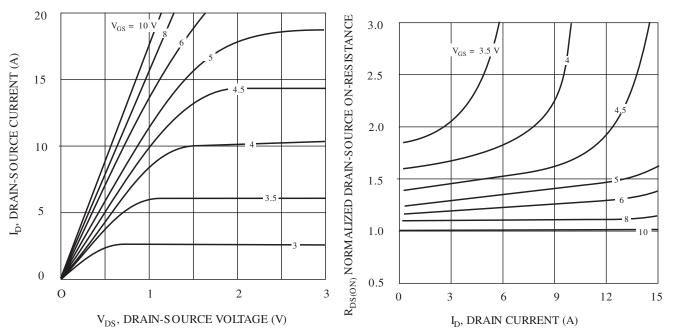


Fig. 1, On-Region Characteristics

Fig. 2, On-Resistance vs Gate Voltage and Drain Current

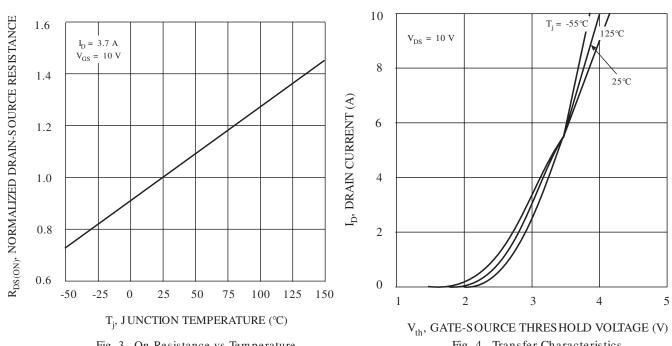


Fig. 3, On-Resistance vs Temperature

Fig. 4, Transfer Characteristics

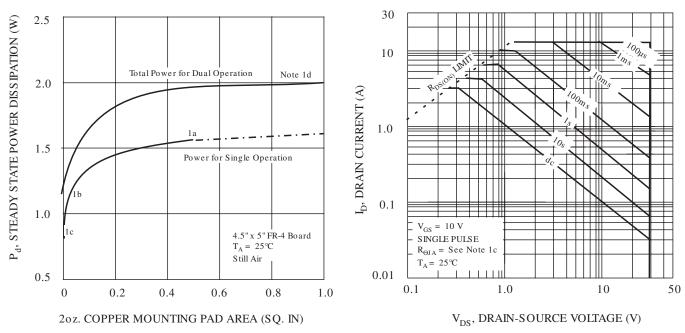


Fig. 5, Steady State Pwr Dissipation vs Copper Mtg Pad Area

Fig. 6, Maximum Safe Operating Area

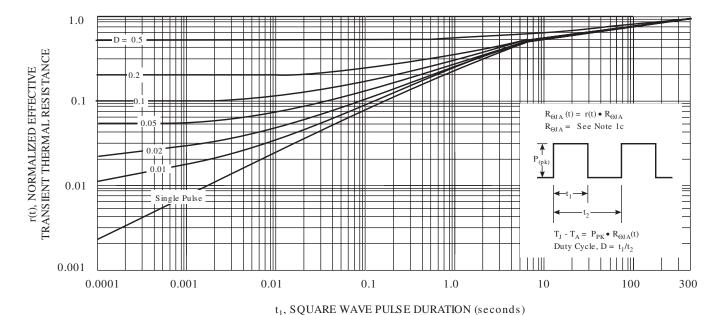


Fig. 7, Typical Normalized Transient Thermal Impedance Curves

Remark: Thermal characterization performed under conditions of Note 1c. Better thermal design such as shown in Notes 1a and 1b or 1d will offer lower $R_{\Theta JA}$ values and allow junction to reach thermal equilibrium sooner.